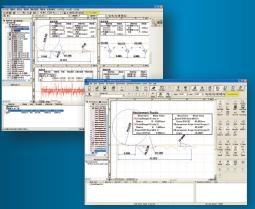
Analysis Software

Mitutoyo

FORMTRACEPAK functions offer total support for measurement system control, surface roughness analysis, contour analysis, contour tolerancing, and inspection report creation.



Contour Measurement Screen

Parathar Hallandphilithal each tearthigh eagail

Surface Roughness Measurement Screen

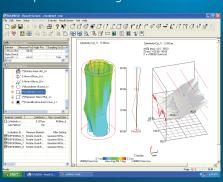
Vision Measuring Systems

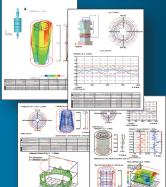




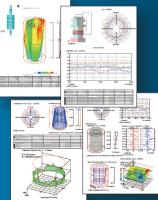
ROUNDPAK

A wide variety of parameters including those for roundness/cylindricity, as well as flatness and parallelism, are provided as standard features. You can visually select these parameters using icons.





Printout



Coordinate Measuring Machines

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Introducing Mitutoyo's Full Line of Form Measuring Equipment

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Remarkable operability and functionality revolutionize contour measuring systems and enable measurement that is fast, accurate,



The 2.4-inch color graphic LCD provides excellent readability and an intuitive display that is easy to navigate.

Surface Roughness Measuring Systems



Data processing unit includes a 5.7-inch color graphic LCD touch-panel and a built-in high-speed thermal printer.



Roundness Measuring Systems







Both skidded and skidless measurement are possible with this series. Equipped with 46 roughness parameters that conform to the latest ISO. DIN. ANSI. and JIS standards.



Semi-portable type that is PC based, capable of measuring in axial direction for parts such as crankshafts by simply swiveling the detector through 90 degrees.















178-076 (S-3000MR) Manual Rotary Type Detector Holder



All models are equipped with a highly accurate turntable that enables simple and accurate centering and leveling of the workpiece, which account for the majority of the essential setup work for measuring roundness/cylindricity.



This model introduces the dual-sided stylus design into the CNC model for the first time. The SV-C 4500CNC is a high accuracy contact type contour and surface roughness measuring system.



CNC Surface Roughness Tester incorporating a column-moving type configuration that is ideal for measuring large/heavy workpiece such as engine blocks and crankshafts.

SV-M3000 CNC



These models offer high measuring accuracy and reliability using automated measurement with independent/simultaneous multiaxis CNC control. Roundness and surface roughness measurements are both available from a single measuring system.

